

Silicon carbide Power MOSFET: 12 A, 1200 V, 550 mΩ (typ., T_J=150 °C), N-channel in an HiP247™ long leads

Datasheet - preliminary data

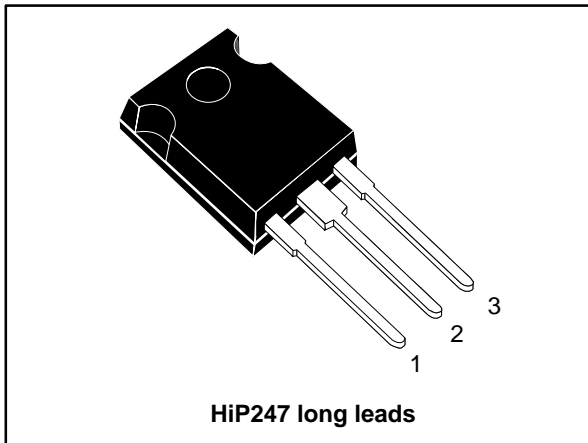
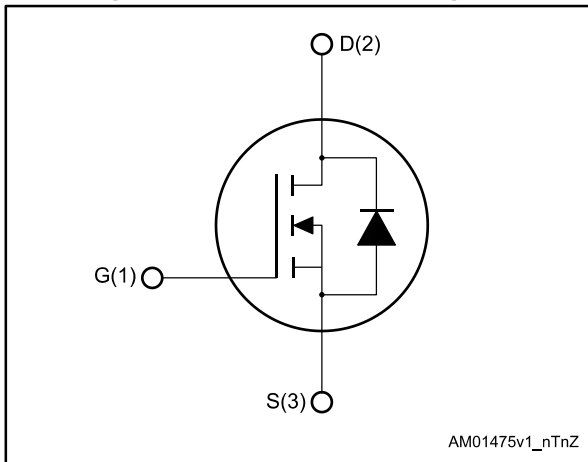


Figure 1: Internal schematic diagram



Features

- Very tight variation of on-resistance vs. temperature
- Slight variation of switching losses vs. temperature
- Very high operating temperature capability (200 °C)
- Very fast and robust intrinsic body diode
- Low capacitance
- Easy to drive

Applications

- Solar inverters, UPS
- Motor drives
- High voltage DC-DC converters
- Switch mode power supplies

Description

This silicon carbide Power MOSFET is produced exploiting the advanced, innovative properties of wide bandgap materials. This results in unsurpassed on-resistance per unit area and very good switching performance almost independent of temperature. The outstanding thermal properties of the SiC material, combined with the device's housing in the proprietary HiP247™ package, allows designers to use an industry-standard outline with significantly improved thermal capability. These features render the device perfectly suitable for high-efficiency and high power density applications.

Table 1: Device summary

Order code	Marking	Package	Packaging
SCTWA10N120	SCT10N120	HiP247™ long leads	Tube



The device meets ECOPACK standards, an environmentally-friendly grade of products commonly referred to as "halogen-free". See [Section 6: "Package information"](#).

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	1200	V
V_{GS}	Gate-source voltage	-10/+25	V
I_D	Drain current (continuous) at $T_C = 25\text{ °C}$	12	A
I_D	Drain current (continuous) at $T_C = 100\text{ °C}$	10	A
$I_{DM}^{(1)}$	Drain current (pulsed)	24	A
P_{TOT}	Total dissipation at $T_C = 25\text{ °C}$	110	W
T_{stg}	Storage temperature range	-55 to 200	°C
T_j	Operating junction temperature range		°C

Notes:

⁽¹⁾Pulse width limited by safe operating area.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	1.6	°C/W
$R_{thj-amb}$	Thermal resistance junction-ambient max	40	°C/W

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified).

Table 4: On/off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	V _{GS} = 0 V, I _D = 1 mA	1200			V
I _{DSS}	Zero gate voltage drain current	V _{DS} = 1200 V, V _{GS} = 0 V			10	μA
		V _{DS} = 1200 V, V _{GS} = 0 V, T _J = 200 °C ⁽¹⁾			100	μA
I _{GSS}	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = +22 /-10 V			100	nA
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 250 μA	1.8	3.5		V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 20 V, I _D = 6 A		520	690	mΩ
		V _{GS} = 20 V, I _D = 6 A, T _J = 150 °C		550		mΩ
		V _{GS} = 20 V, I _D = 6 A, T _J = 200 °C		600		mΩ

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C _{iss}	Input capacitance	V _{DS} = 1000 V, f = 1 MHz, V _{GS} = 0 V	-	300	-	pF
C _{oss}	Output capacitance		-	25	-	pF
C _{rss}	Reverse transfer capacitance		-	9	-	pF
Q _g	Total gate charge	V _{DD} = 800 V, I _D = 6 A, V _{GS} = 0 / 20 V	-	21	-	nC
Q _{gs}	Gate-source charge		-	TBD	-	nC
Q _{gd}	Gate-drain charge		-	TBD	-	nC
R _g	Gate input resistance	f=1 MHz open drain	-	TBD	-	Ω

Table 6: Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
E _{on}	Turn-on switching energy	V _{DD} = 800 V, I _D = 6 A R _G = 4.7 Ω, V _{GS} = -2/20 V	-	TBD	-	μJ
E _{off}	Turn-off switching energy		-	TBD	-	μJ
E _{on}	Turn-on switching energy	V _{DD} = 800 V, I _D = 6 A R _G = 4.7 Ω, V _{GS} = -2/20 V T _J = 150 °C	-	TBD	-	μJ
E _{off}	Turn-off switching energy		-	TBD	-	μJ

Table 7: Switching times

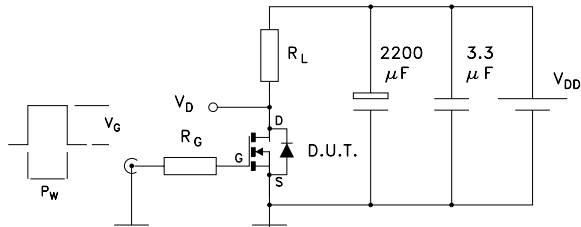
Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 800\text{ V}$, $I_D = 6\text{ A}$, $R_G = 4.7\ \Omega$, $V_{GS} = 0/20\text{ V}$	-	TBD	-	ns
t_f	Fall time		-	TBD	-	ns
$t_{d(off)}$	Turn-off delay time		-	TBD	-	ns
t_r	Rise time		-	TBD	-	ns

Table 8: Reverse SiC diode characteristics

Symbol	Parameter	Test conditions	Min	Typ.	Max	Unit
V_{SD}	Diode forward voltage	$I_F = 3\text{ A}$, $V_{GS} = 0\text{ V}$	-	TBD	-	V
t_{rr}	Reverse recovery time	$I_{SD} = 6\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$ $V_{DD} = 800\text{ V}$	-	TBD	-	ns
Q_{rr}	Reverse recovery charge		-	TBD	-	nC
I_{RRM}	Reverse recovery current		-	TBD	-	A

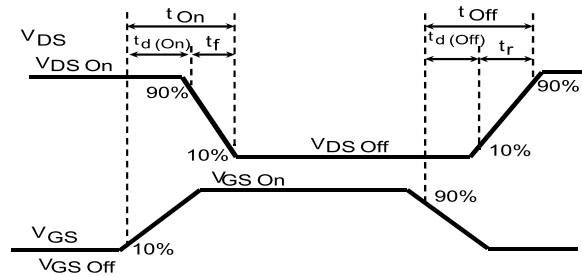
3 Test circuits

Figure 2: Switching test waveforms for transition times



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Figure 3: Clamped inductive switching waveform



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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 HiP247™ long leads package information

Figure 4: HiP247™ long leads package outline

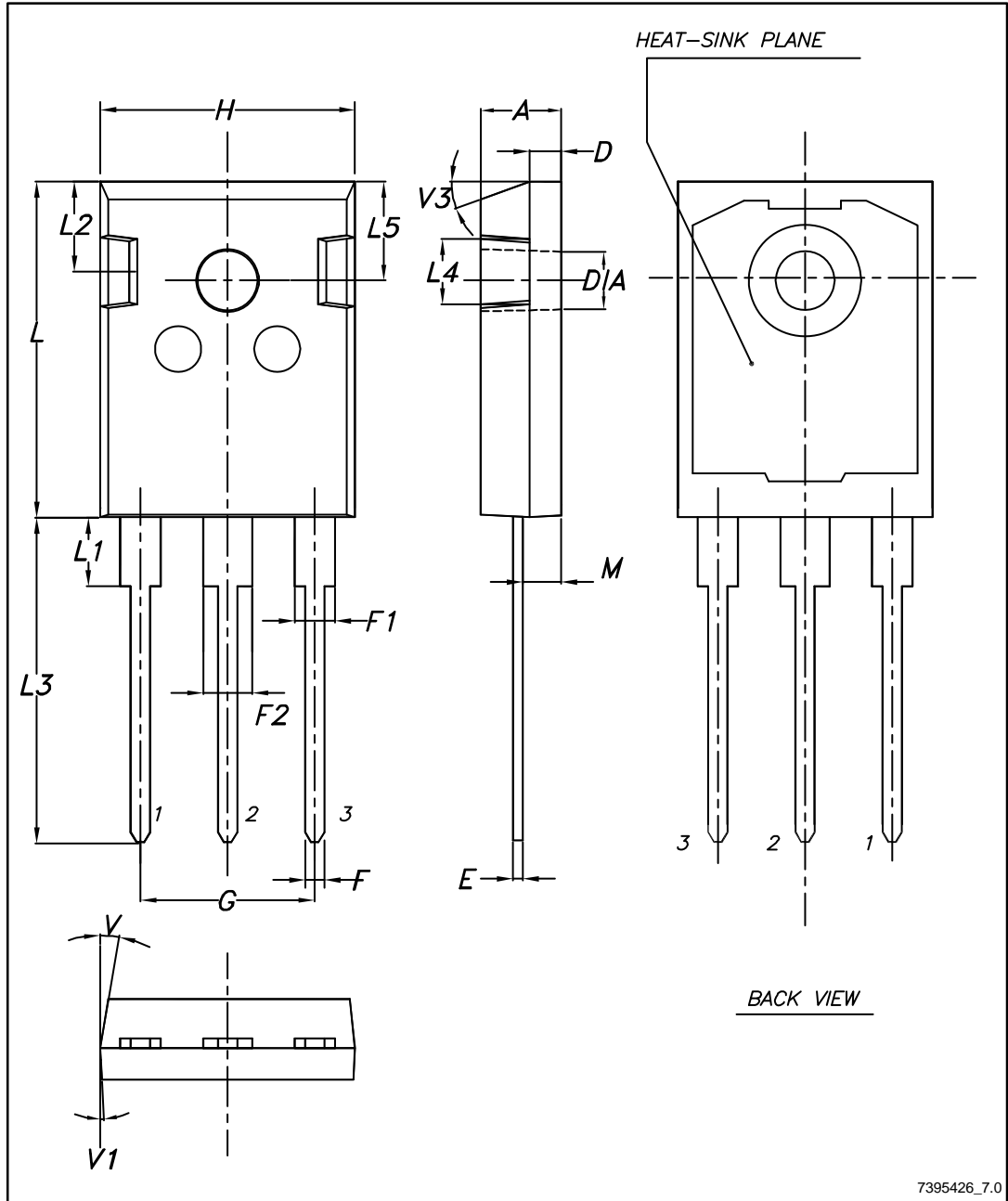


Table 9: HiP247™ long leads package mechanical data

Dim.	mm.		
	Min.	Typ.	Max.
A	4.90		5.15
D	1.85		2.10
E	0.55		0.67
F	1.07		1.32
F1	1.90		2.38
F2	2.87		3.38
G	10.90 BSC		
H	15.77		16.02
L	20.82		21.07
L1	4.16		4.47
L2	5.49		5.74
L3	20.05		20.30
L4	3.68		3.93
L5	6.04		6.29
M	2.25		2.55
V		10°	
V1		3°	
V3		20°	
DIA	3.55		3.66

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
29-Feb-2016	1	First release

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